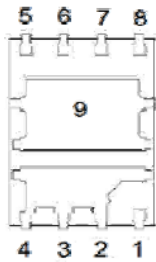
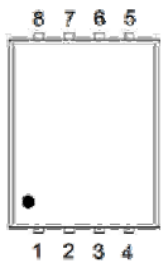


# P0903YK

## Dual N-Channel Enhancement Mode MOSFET

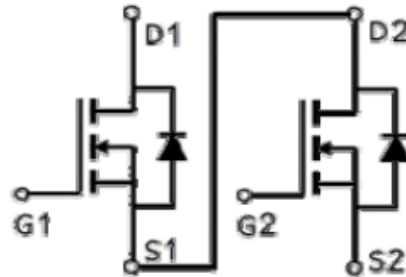
### PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D^3$	CH.
30V	9mΩ @ $V_{GS} = 10V$	51A	Q2
30V	16mΩ @ $V_{GS} = 10V$	31A	Q1



1 : G1  
2,3,4 : D1  
5,6,7 : S2  
8 : G2  
9 : S1/D2

PDFN 5\*6P



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ }^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	CH.	LIMITS	UNITS
Drain-Source Voltage		$V_{DS}$	Q2	30	V
			Q1	30	
Gate-Source Voltage		$V_{GS}$	Q2	±20	
			Q1	±20	
Continuous Drain Current <sup>3</sup>	$T_C = 25\text{ }^\circ\text{C}$	$I_D$	Q2	51	A
			Q1	31	
	$T_C = 100\text{ }^\circ\text{C}$		Q2	32	
			Q1	20	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	Q2	100	A
			Q1	80	
Continuous Drain Current	$T_A = 25\text{ }^\circ\text{C}$	$I_D$	Q2	11	A
			Q1	8.5	
	$T_A = 70\text{ }^\circ\text{C}$		Q2	9	
			Q1	6.7	
Avalanche Current		$I_{AS}$	Q2	23	A
			Q1	17	
Avalanche Energy	$L = 0.1\text{mH}$	$E_{AS}$	Q2	24	mJ
			Q1	14.5	
Power Dissipation	$T_C = 25\text{ }^\circ\text{C}$	$P_D$	Q2	39	W
			Q1	27	
	$T_C = 100\text{ }^\circ\text{C}$		Q2	15	
			Q1	11	

# P0903YK

## Dual N-Channel Enhancement Mode MOSFET

Power Dissipation	$T_A = 25\text{ }^\circ\text{C}$	$P_D$	Q2	2	W
	$T_A = 70\text{ }^\circ\text{C}$		Q1	1.8	
			Q2	1.3	
	Q1		1.1		
Operating Junction & Storage Temperature Range		$T_J, T_{STG}$	-55 to 150		$^\circ\text{C}$

### THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	CH.	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient <sup>2</sup>	$R_{\theta JA}$	Q2		60	$^\circ\text{C} / \text{W}$
		Q1		67	
Junction-to-Case	$R_{\theta JC}$	Q2		3.2	
		Q1		4.5	

<sup>1</sup>Pulse width limited by maximum junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .

<sup>2</sup>The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

<sup>3</sup>Package limitation current :Q1=20A,Q2=23A.

### ELECTRICAL CHARACTERISTICS ( $T_J = 25\text{ }^\circ\text{C}$ , Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	CH.	LIMITS			UNITS
				MIN	TYP	MAX	
<b>STATIC</b>							
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	Q2	30			V
			Q1	30			
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	Q2	1	1.6	3	V
			Q1	1	1.6	3	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 20V$	Q2			$\pm 100$	nA
			Q1			$\pm 100$	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 24V, V_{GS} = 0V$	Q2			1	$\mu\text{A}$
			Q1			1	
		$V_{DS} = 20V, V_{GS} = 0V, T_J = 55\text{ }^\circ\text{C}$	Q2			10	
			Q1			10	
Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(ON)}$	$V_{GS} = 4.5V, I_D = 9A$	Q2		9.9	14.5	m $\Omega$
		$V_{GS} = 4.5V, I_D = 6.8A$	Q1		16	25	
		$V_{GS} = 10V, I_D = 11A$	Q2		7.9	9	
		$V_{GS} = 10V, I_D = 8.5A$	Q1		12	16	
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 11A$	Q2		50		S
		$V_{DS} = 5V, I_D = 8.5A$	Q1		36		

# P0903YK

## Dual N-Channel Enhancement Mode MOSFET

DYNAMIC							
Input Capacitance	$C_{iss}$	$V_{GS} = 0V,$ $V_{DS} = 15V, f = 1MHz$	Q2		954	pF	
			Q1		535		
Output Capacitance	$C_{oss}$		Q2		124		
			Q1		81		
Reverse Transfer Capacitance	$C_{rss}$		Q2		104		
			Q1		75		
Gate Resistance	$R_g$	$V_{GS} = 0V,$ $V_{DS} = 0V, f = 1MHz$	Q2		2.1	$\Omega$	
			Q1		2.3		
Total Gate Charge <sup>2</sup>	$Q_g$	$Q2$ $V_{DS} = 15V,$ $V_{GS} = 10V, I_D = 11A$ $Q1$ $V_{DS} = 15V,$ $V_{GS} = 10V, I_D = 8.5A$	$V_{GS}=10V$	Q2		21.7	nC
				Q1		15.1	
			$V_{GS}=4.5V$	Q2		11.5	
				Q1		8.3	
Gate-Source Charge <sup>2</sup>	$Q_{gs}$		Q2		3.3		
			Q1		2		
Gate-Drain Charge <sup>2</sup>	$Q_{gd}$		Q2		5.6		
			Q1		5		
Turn-On Delay Time <sup>2</sup>	$t_{d(on)}$	$Q2$ $V_{DS} = 15V, I_D \cong 11A,$ $V_{GS}=10V, R_{GEN} = 6\Omega$	Q2		24	nS	
			Q1		20		
Rise Time <sup>2</sup>	$t_r$	$Q1$ $V_{DS} = 15V, I_D \cong 8.5A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	Q2		16		
			Q1		16		
Turn-Off Delay Time <sup>2</sup>	$t_{d(off)}$		Q2		44		
			Q1		53		
Fall Time <sup>2</sup>	$t_f$		Q2		23		
			Q1		33		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ( $T_J = 25^\circ C$ )							
Continuous Current <sup>3</sup>	$I_S$		Q2		51	A	
			Q1		31		
Forward Voltage <sup>1</sup>	$V_{SD}$	$I_F = 11A, V_{GS} = 0V$	Q2		1.2	V	
		$I_F = 8.5A, V_{GS} = 0V$	Q1		1		
Reverse Recovery Time	$t_{rr}$	$Q2$ $I_F = 11A, di_F/dt = 100A/\mu S$ $Q1$ $I_F = 8.5A, di_F/dt = 100A/\mu S$	Q2		17	nS	
			Q1		15		
Reverse Recovery Charge	$Q_{rr}$			Q2		7	nC
				Q1		5.6	

<sup>1</sup>Pulse test : Pulse Width  $\leq 300 \mu sec$ , Duty Cycle  $\leq 2\%$ .

<sup>2</sup>Independent of operating temperature.

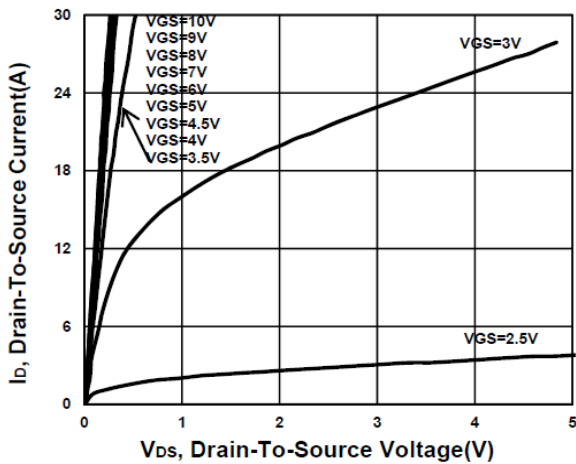
<sup>3</sup>Package limitation current :Q1=20A,Q2=23A.

# P0903YK

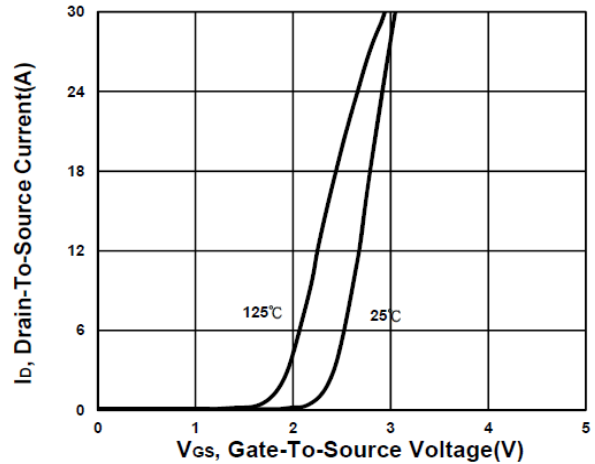
## Dual N-Channel Enhancement Mode MOSFET

Q2

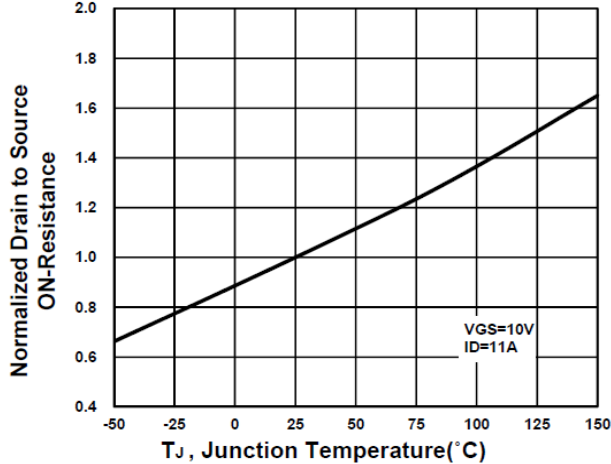
**Output Characteristics**



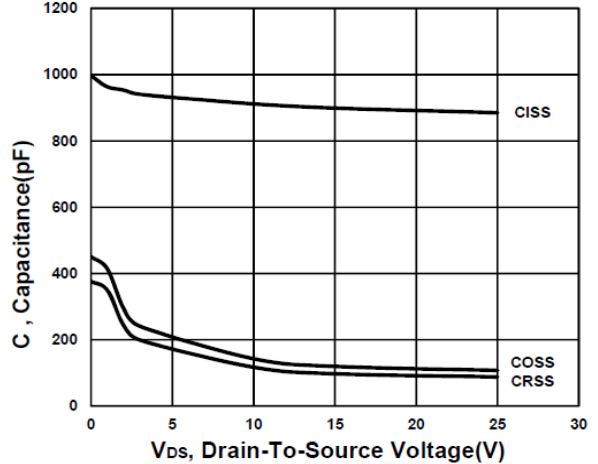
**Transfer Characteristics**



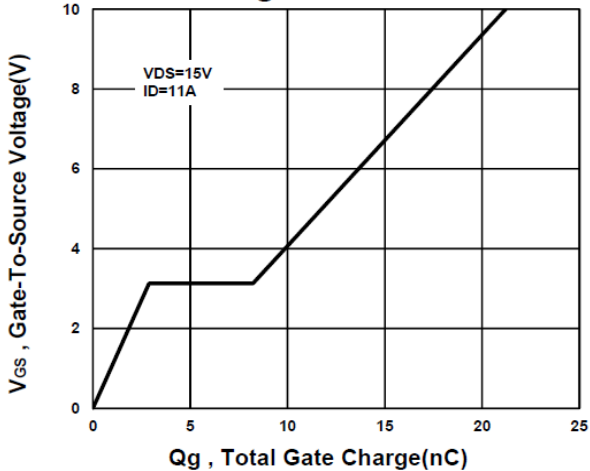
**On-Resistance VS Temperature**



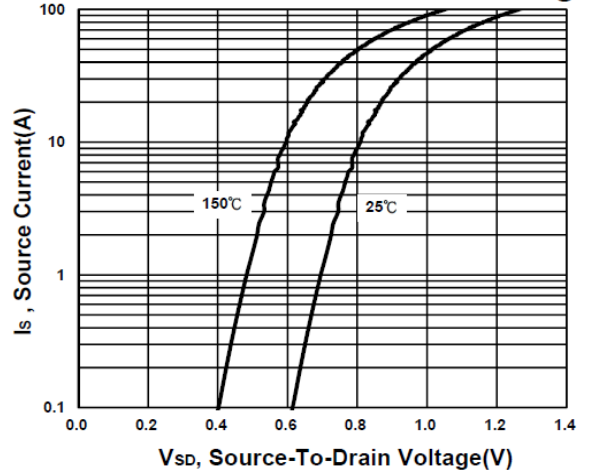
**Capacitance Characteristic**



**Gate charge Characteristics**



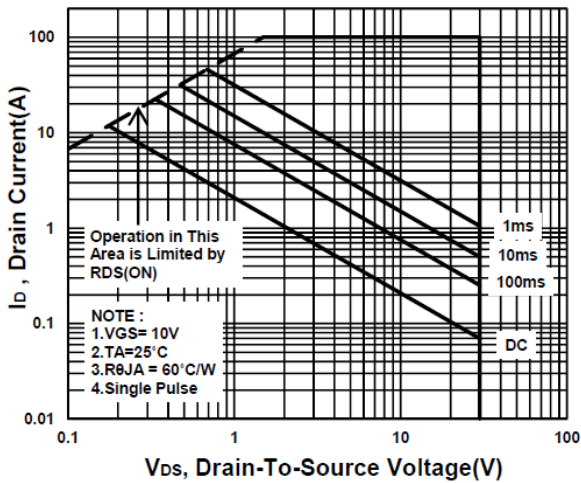
**Source-Drain Diode Forward Voltage**



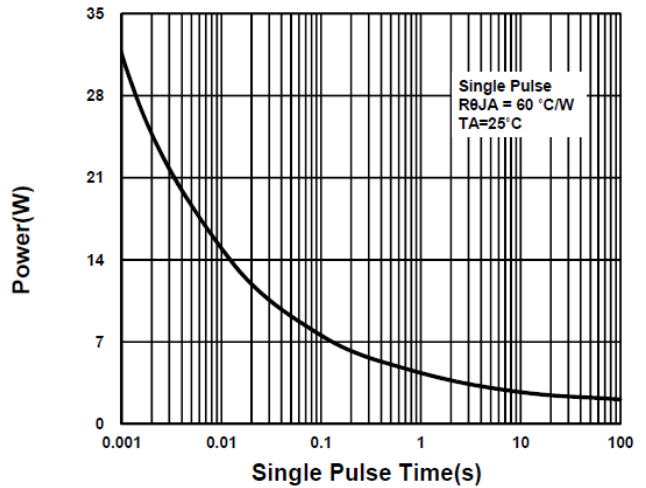
# P0903YK

## Dual N-Channel Enhancement Mode MOSFET

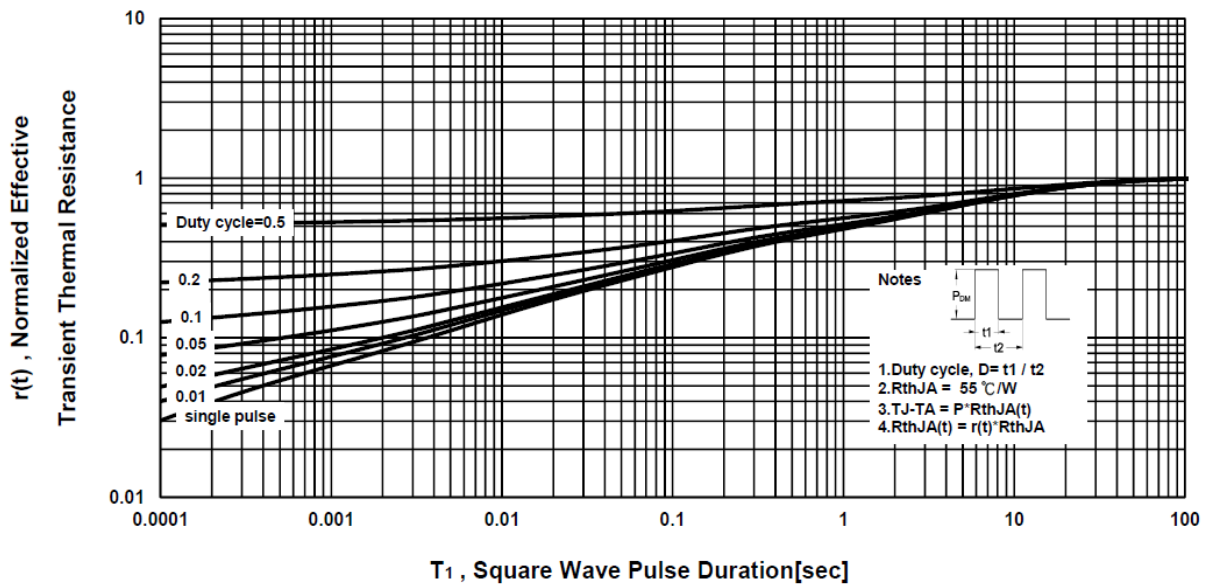
**Safe Operating Area**



**Single Pulse Maximum Power Dissipation**



**Transient Thermal Response Curve**

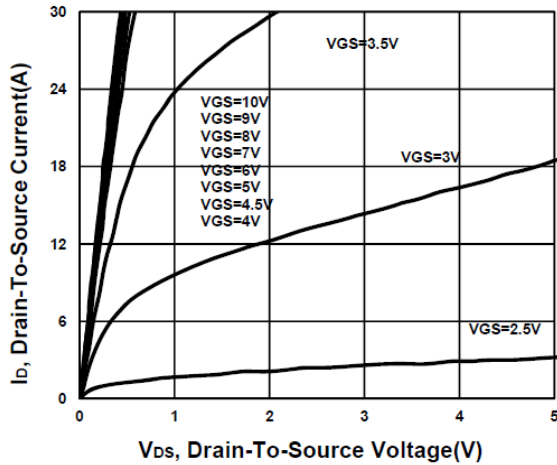


# P0903YK

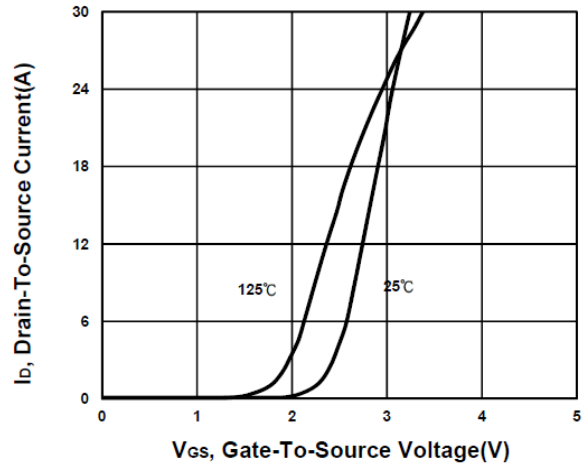
## Dual N-Channel Enhancement Mode MOSFET

Q1

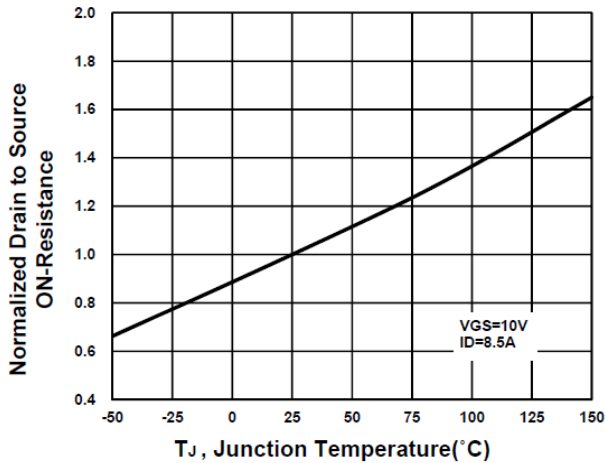
**Output Characteristics**



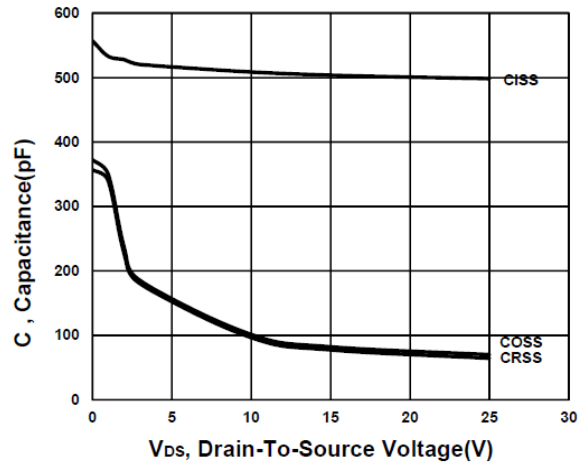
**Transfer Characteristics**



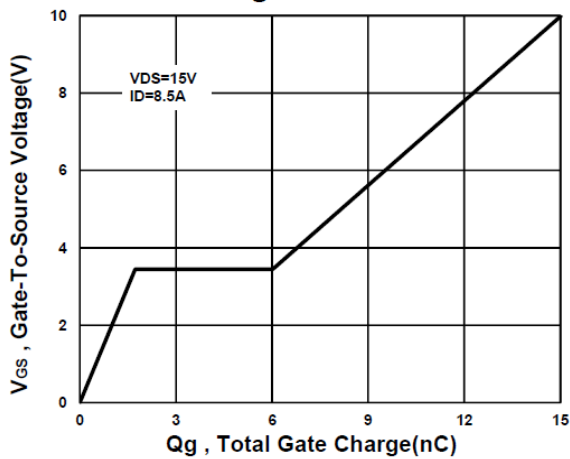
**On-Resistance VS Temperature**



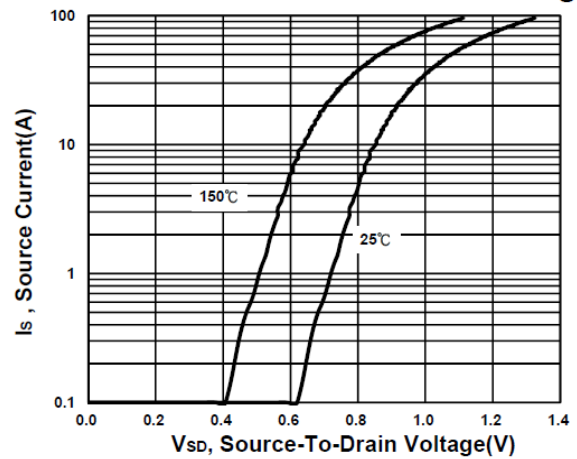
**Capacitance Characteristic**



**Gate charge Characteristics**



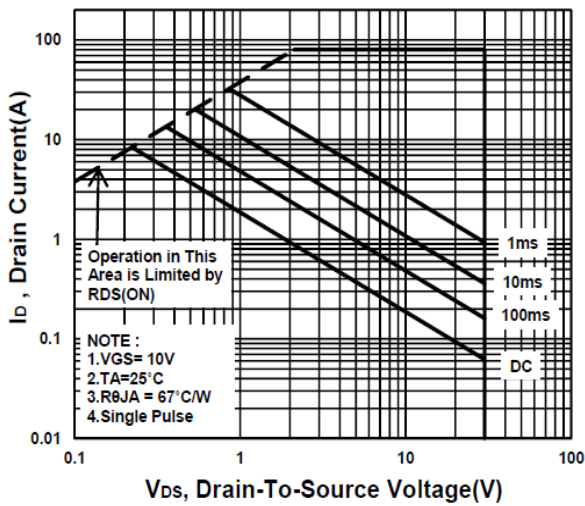
**Source-Drain Diode Forward Voltage**



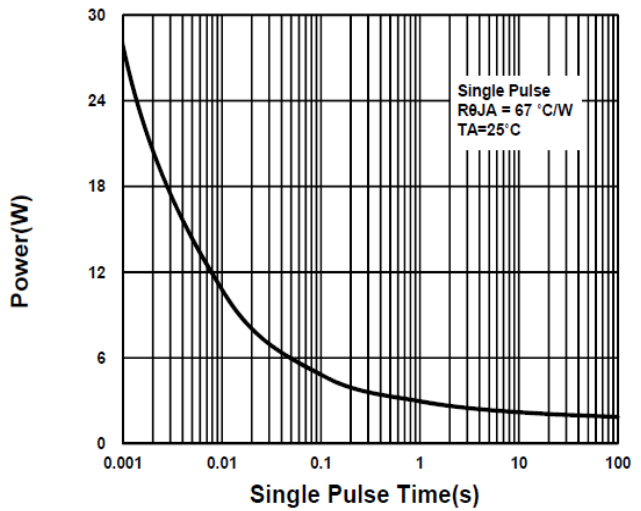
# P0903YK

## Dual N-Channel Enhancement Mode MOSFET

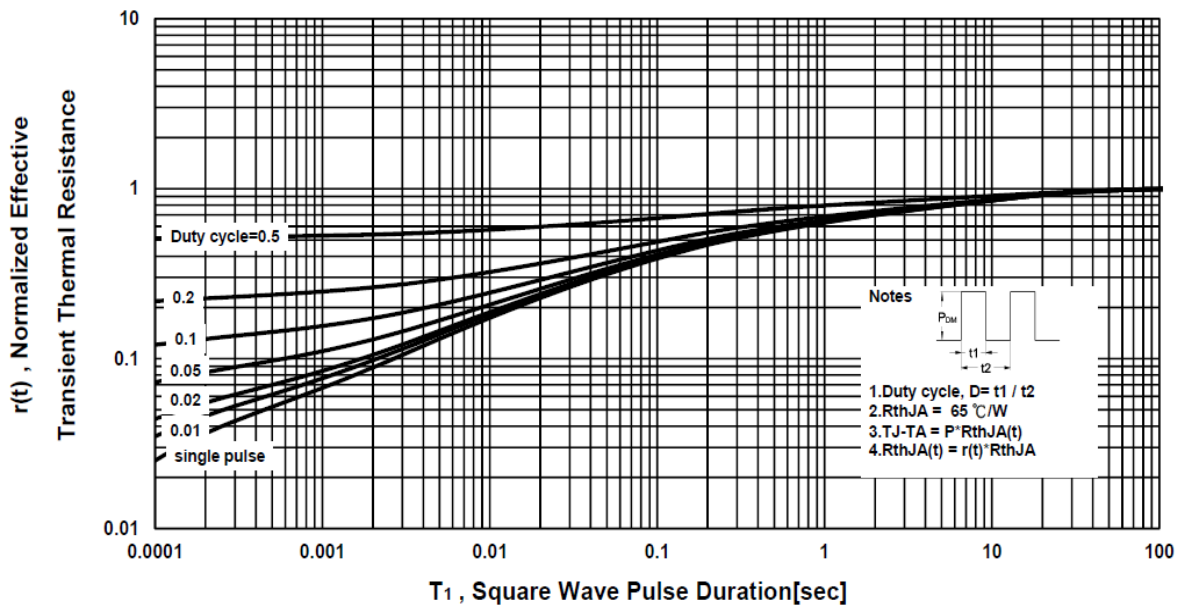
**Safe Operating Area**



**Single Pulse Maximum Power Dissipation**



**Transient Thermal Response Curve**



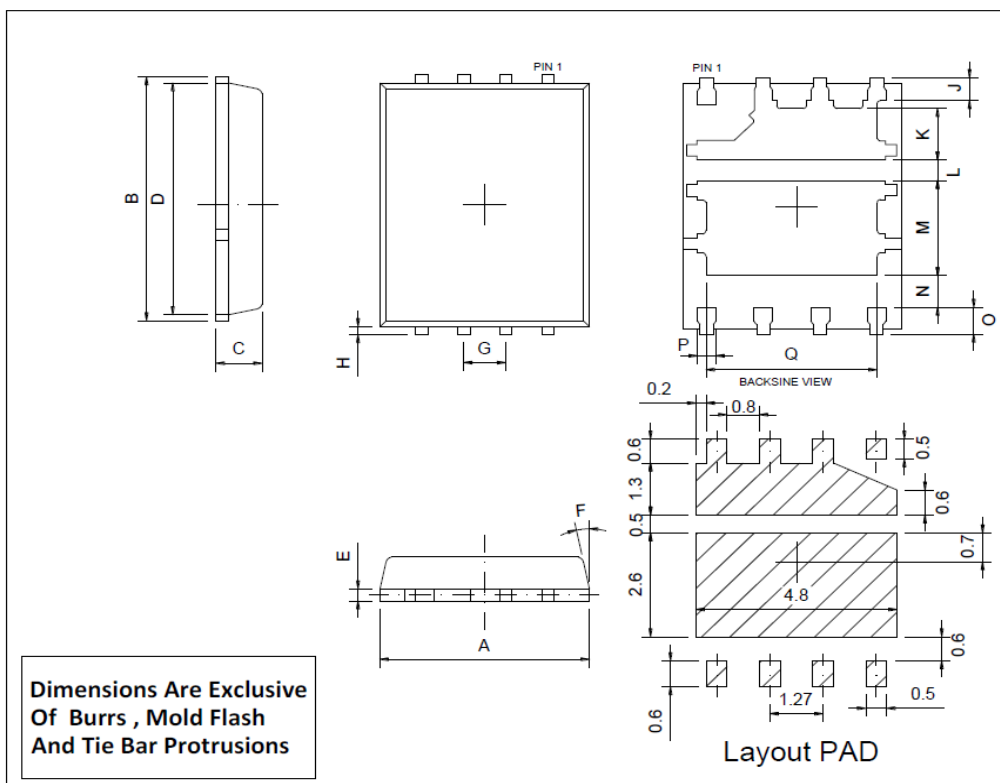
# P0903YK

## Dual N-Channel Enhancement Mode MOSFET

### Package Dimension

### PDFN 5x6P(上下 Dual) MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	4.8	5	5.4	K	0.82	1.06	1.3
B	5.9	6.15	6.35	L	0.4	0.5	0.6
C	0.9	1	1.18	M	2.0	2.21	2.42
D	5.42	5.59	5.85	N	0.5	1	
E	0.15	0.25	0.35	O	0.42	0.56	0.71
F	0°	6°	12°	P	0.3	0.4	0.51
G	1.17	1.27	1.37	Q	3.61	4.05	4.5
H	0.06	0.21	0.36				
J	0.41	0.55	0.7				

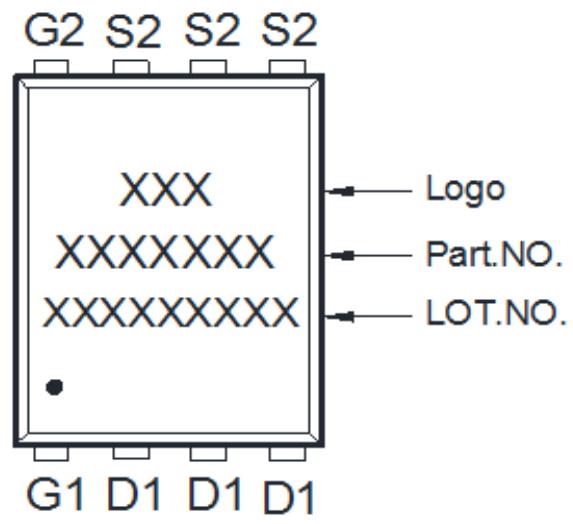


\* 散热片形状会因为封装厂框架不同而有所差异。

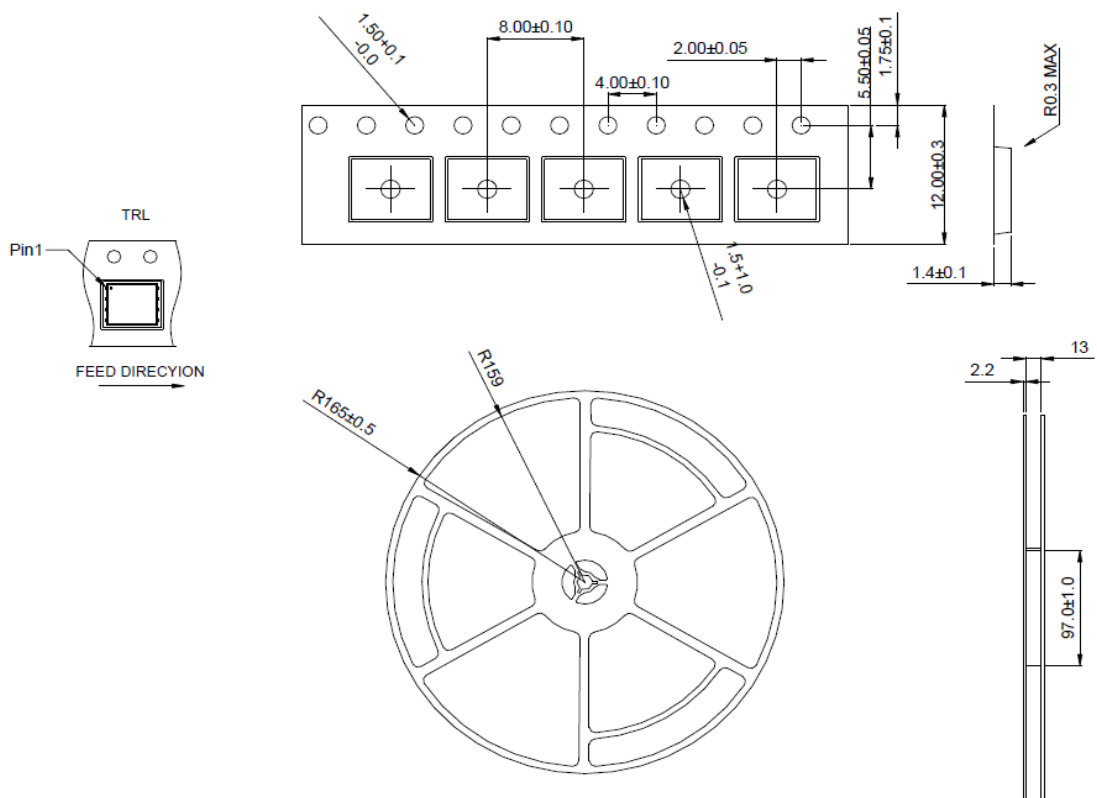


**P0903YK**  
**Dual N-Channel Enhancement Mode MOSFET**

**A. Marking Information**



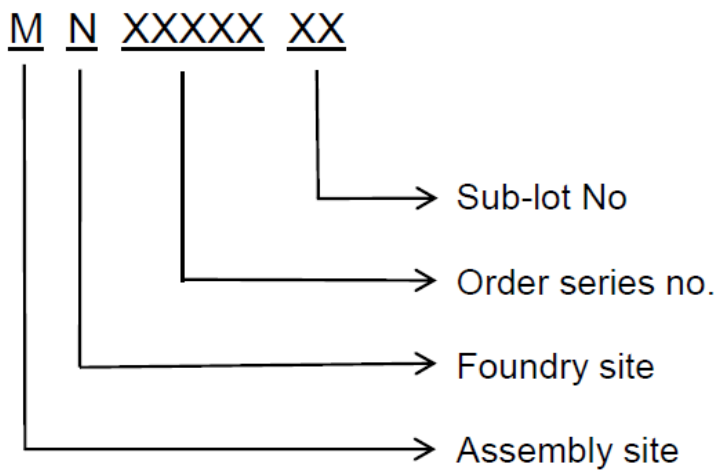
**B. Tape & Reel Information: 3000pcs/Reel**



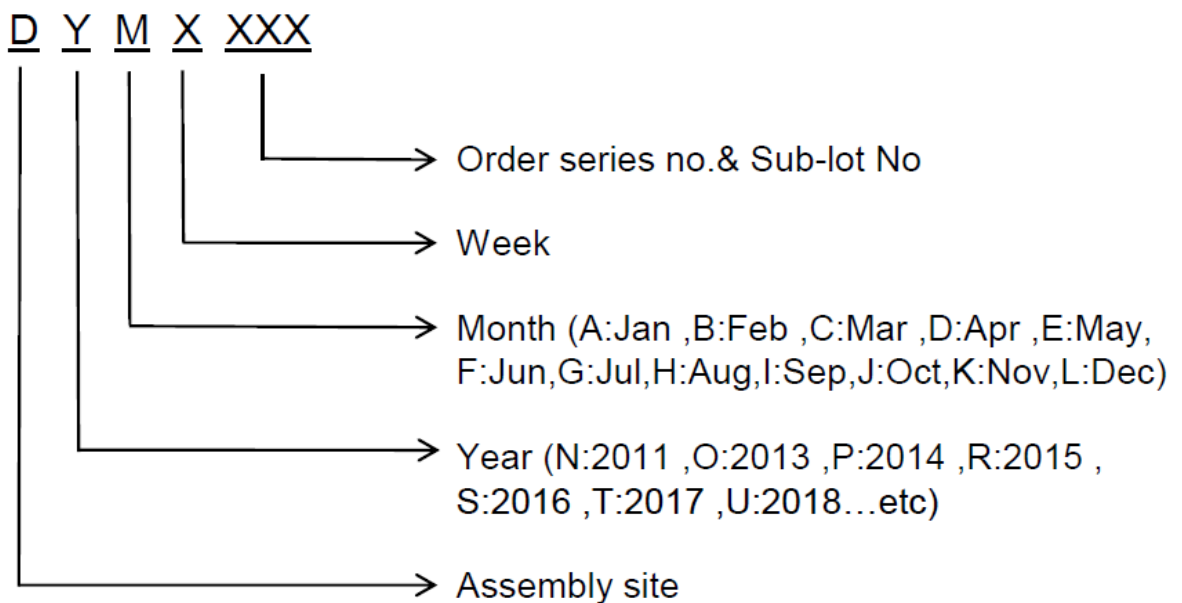
**P0903YK**  
**Dual N-Channel Enhancement Mode MOSFET**

**C. Lot No.&Date Code rule**

1.Lot No.



2.Date Code





# P0903YK

## Dual N-Channel Enhancement Mode MOSFET

### D.Label rule

标签内容(Label content)



1	Label Size	30 * 90 mm
2	Font style	Times New Roman or Arial (或可区分英文”0”和数字”0”，”G和”Q”的字型即可)
3	U-NIKC	Height: 4 mm
4	Package	Height: 2 mm
5	Date	Height: 2 mm Shipping date: YYYY/MM/DD, ex. 2008/09/12
6	Device	Height: 3 mm (Max: 16 Digit)
7	Lot	Height: 3 mm (Max: 9 Digit) Sub lot
8	D/C	Height: 3 mm (Max: 7 Digit)
9	QTY	Height: 3 mm (Max: 6 Digit) Thousand mark is no needed
10	RoHS label	 long axis: 12 mm minor axis:6 mm bottom color: White Font color: Black Font style: Arial
11	Halogen Free label	 Diameter: 10 mm bottom color: Green Font color: Black Font style: Arial
12	Scan information	Device / Lot / D/C / QTY , Insert “ / “ between every parts. for example: P3055LDG/G12345601/GGG2301/2000 DPI (Dots per inch): Over 300 dpi Code : Code 128 Height: 6 mm at least